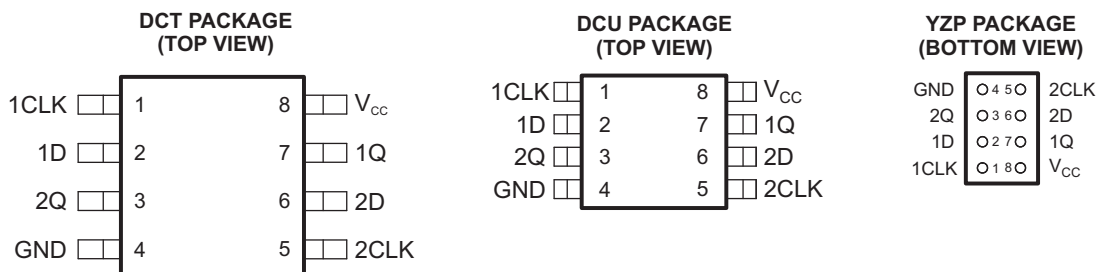


FEATURES

- Available in the Texas Instruments NanoFree™ Package
- Optimized for 1.8-V Operation and Is 3.6-V I/O Tolerant to Support Mixed-Mode Signal Operation
- I_{off} Supports Partial Power-Down-Mode Operation
- Sub-1-V Operable
- Max t_{pd} of 1.9 ns at 1.8 V
- Low Power Consumption, 10-μA Max I_{CC}
- ±8-mA Output Drive at 1.8 V
- Latch-Up Performance Exceeds 100 mA Per JESD 78, Class II
- ESD Performance Tested Per JESD 22
 - 2000-V Human-Body Model (A114-B, Class II)
 - 200-V Machine Model (A115-A)
 - 1000-V Charged-Device Model (C101)



See mechanical drawings for dimensions.

DESCRIPTION/ORDERING INFORMATION

This single positive-edge-triggered D-type flip-flop is operational at 0.8-V to 2.7-V V_{CC}, but is designed specifically for 1.65-V to 1.95-V V_{CC} operation.

When data at the data (D) input meets the setup time requirement, the data is transferred to the Q output on the positive-going edge of the clock pulse. Clock triggering occurs at a voltage level and is not directly related to the rise time of the clock pulse. Following the hold-time interval, data at the D input can be changed without affecting the levels at the outputs.

NanoFree™ package technology is a major breakthrough in IC packaging concepts, using the die as the package.

This device is fully specified for partial-power-down applications using I_{off}. The I_{off} circuitry disables the outputs, preventing damaging current backflow through the device when it is powered down.

ORDERING INFORMATION

| T _A | PACKAGE ⁽¹⁾ | | ORDERABLE PART NUMBER | TOP-SIDE MARKING ⁽²⁾ |
|----------------|--|--------------|-----------------------|---------------------------------|
| -40°C to 85°C | NanoFree™ – WCSP (DSBGA) 0.23-mm Large Bump – YZP (Pb-free) | Reel of 3000 | SN74AUC2G79YZPR | ___UR_ |
| | SSOP – DCT | Reel of 3000 | SN74AUC2G79DCTR | U79___ |
| | VSSOP – DCU | Reel of 3000 | SN74AUC2G79DCUR | U79_ |

(1) Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.

(2) DCT: The actual top-side marking has three additional characters that designate the year, month, and assembly/test site.

DCU: The actual top-side marking has one additional character that designates the assembly/test site.

YZP: The actual top-side marking has three preceding characters to denote year, month, and sequence code, and one following character to designate the assembly/test site. Pin 1 identifier indicates solder-bump composition (1 = SnPb, • = Pb-free).



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

NanoFree is a trademark of Texas Instruments.

Recommended Operating Conditions⁽¹⁾

| | | MIN | MAX | UNIT |
|-----------------|------------------------------------|--|------------------------|------|
| V _{CC} | Supply voltage | 0.8 | 2.7 | V |
| V _{IH} | High-level input voltage | V _{CC} = 0.8 V | V _{CC} | V |
| | | V _{CC} = 1.1 V to 1.95 V | 0.65 × V _{CC} | |
| | | V _{CC} = 2.3 V to 2.7 V | 1.7 | |
| V _{IL} | Low-level input voltage | V _{CC} = 0.8 V | 0 | V |
| | | V _{CC} = 1.1 V to 1.95 V | 0.35 × V _{CC} | |
| | | V _{CC} = 2.3 V to 2.7 V | 0.7 | |
| V _I | Input voltage | 0 | 3.6 | V |
| V _O | Output voltage | 0 | V _{CC} | V |
| I _{OH} | High-level output current | V _{CC} = 0.8 V | −0.7 | mA |
| | | V _{CC} = 1.1 V | −3 | |
| | | V _{CC} = 1.4 V | −5 | |
| | | V _{CC} = 1.65 V | −8 | |
| | | V _{CC} = 2.3 V | −9 | |
| I _{OL} | Low-level output current | V _{CC} = 0.8 V | 0.7 | mA |
| | | V _{CC} = 1.1 V | 3 | |
| | | V _{CC} = 1.4 V | 5 | |
| | | V _{CC} = 1.65 V | 8 | |
| | | V _{CC} = 2.3 V | 9 | |
| Δt/Δv | Input transition rise or fall rate | V _{CC} = 0.8 V to 1.65 V ⁽²⁾ | 20 | ns/V |
| | | V _{CC} = 1.65 V to 2.3 V ⁽³⁾ | 20 | |
| | | V _{CC} = 2.3 V to 2.7 V ⁽³⁾ | 20 | |
| T _A | Operating free-air temperature | −40 | 85 | °C |

(1) All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, *Implications of Slow or Floating CMOS Inputs*, literature number SCBA004.

(2) The data was taken at C_L = 15 pF, R_L = 2 kΩ (see Figure 1).

(3) The data was taken at C_L = 30 pF, R_L = 500 Ω (see Figure 1).

Electrical Characteristics

over recommended operating free-air temperature range (unless otherwise noted)

| PARAMETER | | TEST CONDITIONS | V _{CC} | MIN | TYP ⁽¹⁾ | MAX | UNIT |
|------------------|-----------------|---|-----------------|-----------------------|--------------------|-----|------|
| V _{OH} | | I _{OH} = -100 μA | 0.8 V to 2.7 V | V _{CC} - 0.1 | | | V |
| | | I _{OH} = -0.7 mA | 0.8 V | 0.55 | | | |
| | | I _{OH} = -3 mA | 1.1 V | 0.8 | | | |
| | | I _{OH} = -5 mA | 1.4 V | 1 | | | |
| | | I _{OH} = -8 mA | 1.65 V | 1.2 | | | |
| | | I _{OH} = -9 mA | 2.3 V | 1.8 | | | |
| V _{OL} | | I _{OL} = 100 μA | 0.8 V to 2.7 V | 0.2 | | | V |
| | | I _{OL} = 0.7 mA | 0.8 V | 0.25 | | | |
| | | I _{OL} = 3 mA | 1.1 V | 0.3 | | | |
| | | I _{OL} = 5 mA | 1.4 V | 0.4 | | | |
| | | I _{OL} = 8 mA | 1.65 V | 0.45 | | | |
| | | I _{OL} = 9 mA | 2.3 V | 0.6 | | | |
| I _I | D or CLK inputs | V _I = V _{CC} or GND | 0 to 2.7 V | ±5 | | | μA |
| I _{off} | | V _I or V _O = 2.7 V | 0 | ±10 | | | μA |
| I _{CC} | | V _I = V _{CC} or GND, I _O = 0 | 0.8 V to 2.7 V | 10 | | | μA |
| C _i | | V _I = V _{CC} or GND | 2.5 V | 2.5 | | | pF |

(1) All typical values are at T_A = 25°C.

Timing Requirements

over recommended operating free-air temperature range (unless otherwise noted) (see Figure 1)

| | | V _{CC} = 0.8 V | V _{CC} = 1.2 V ± 0.1 V | V _{CC} = 1.5 V ± 0.1 V | V _{CC} = 1.8 V ± 0.15 V | V _{CC} = 2.5 V ± 0.2 V | UNIT |
|--------------------|---------------------------------|-------------------------|------------------------------------|------------------------------------|-------------------------------------|------------------------------------|------|
| | | TYP | MIN MAX | MIN MAX | MIN MAX | MIN MAX | |
| f _{clock} | Clock frequency | 50 | 200 | 225 | 250 | 275 | MHz |
| t _w | Pulse duration, CLK high or low | 2.4 | 1 | 1 | 1 | 1 | ns |
| t _{su} | Setup time before CLK↑ | 1.6 | 0.9 | 0.6 | 0.6 | 0.5 | ns |
| t _h | Hold time, data after CLK↑ | 0 | 0 | 0 | 0.1 | 0.1 | ns |

Switching Characteristics

over recommended operating free-air temperature range, C_L = 15 pF (unless otherwise noted) (see Figure 1)

| PARAMETER | FROM (INPUT) | TO (OUTPUT) | V _{CC} = 0.8 V | V _{CC} = 1.2 V ± 0.1 V | V _{CC} = 1.5 V ± 0.1 V | V _{CC} = 1.8 V ± 0.15 V | V _{CC} = 2.5 V ± 0.2 V | UNIT |
|------------------|--------------|-------------|-------------------------|------------------------------------|------------------------------------|-------------------------------------|------------------------------------|------|
| | | | TYP | MIN MAX | MIN MAX | MIN TYP MAX | MIN MAX | |
| f _{max} | | | 50 | 200 | 225 | 250 | 275 | MHz |
| t _{pd} | CLK | Q | 5 | 1 3.9 | 0.8 2.5 | 0.3 1 1.9 | 0.3 1.3 | ns |

Switching Characteristics

over recommended operating free-air temperature range, C_L = 30 pF (unless otherwise noted) (see Figure 1)

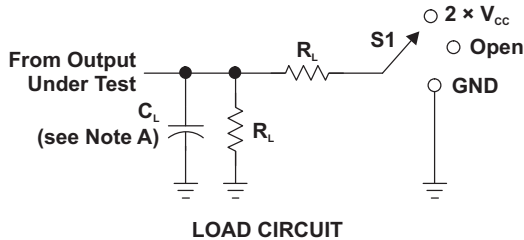
| PARAMETER | FROM (INPUT) | TO (OUTPUT) | V _{CC} = 1.8 V ± 0.15 V | | | V _{CC} = 2.5 V ± 0.2 V | | UNIT |
|------------------|--------------|-------------|-------------------------------------|-----|-----|------------------------------------|-----|------|
| | | | MIN | TYP | MAX | MIN | MAX | |
| f _{max} | | | 250 | | | 275 | | ns |
| t _{pd} | CLK | Q | 0.8 | 1.5 | 2.4 | 0.6 | 1.8 | ns |

Operating Characteristics

$T_A = 25^\circ\text{C}$

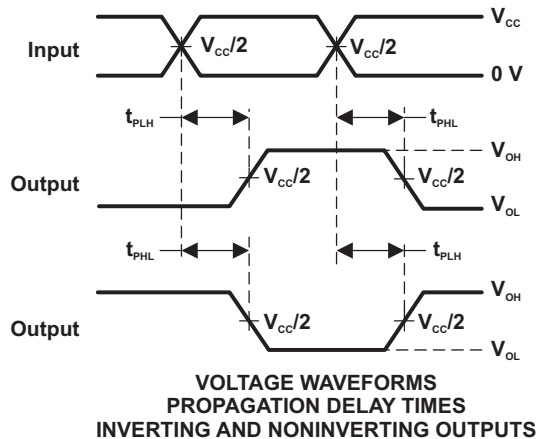
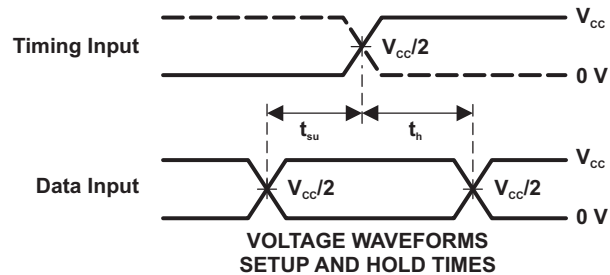
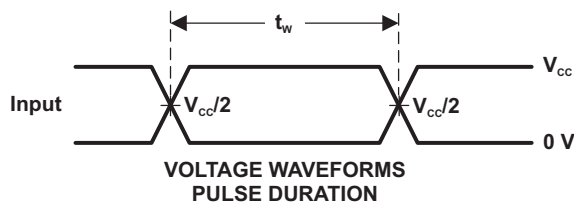
| PARAMETER | | TEST CONDITIONS | $V_{CC} = 0.8\text{ V}$ | $V_{CC} = 1.2\text{ V}$ | $V_{CC} = 1.5\text{ V}$ | $V_{CC} = 1.8\text{ V}$ | $V_{CC} = 2.5\text{ V}$ | UNIT |
|-----------|-------------------|-----------------|-------------------------|-------------------------|-------------------------|-------------------------|-------------------------|------|
| | | | TYP | TYP | TYP | TYP | TYP | |
| C_{pd} | Power dissipation | f = 10 MHz | 16 | 16.2 | 18 | 19.8 | 29.2 | pF |
| | capacitance | | 1.1 | 1.1 | 1.2 | 1.5 | 2.7 | |
| | Total | | 17.1 | 17.3 | 19.2 | 21.3 | 31.9 | |

PARAMETER MEASUREMENT INFORMATION



| TEST | S1 |
|-------------------|-------------------|
| t_{PLH}/t_{PHL} | Open |
| t_{PZL}/t_{PZH} | $2 \times V_{CC}$ |
| t_{PHZ}/t_{PZH} | GND |

| V_{CC} | C_L | R_L | V_A |
|--------------------|-------|--------------|--------|
| 0.8 V | 15 pF | 2 k Ω | 0.1 V |
| 1.2 V \pm 0.1 V | 15 pF | 2 k Ω | 0.1 V |
| 1.5 V \pm 0.1 V | 15 pF | 2 k Ω | 0.1 V |
| 1.8 V \pm 0.15 V | 15 pF | 2 k Ω | 0.15 V |
| 2.5 V \pm 0.2 V | 15 pF | 2 k Ω | 0.15 V |
| 1.8 V \pm 0.15 V | 30 pF | 1 k Ω | 0.15 V |
| 2.5 V \pm 0.2 V | 30 pF | 500 Ω | 0.15 V |



- NOTES: A. C_L includes probe and jig capacitance.
 B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
 C. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, $Z_o = 50 \Omega$, slew rate \geq 1 V/ns.
 D. The outputs are measured one at a time, with one transition per measurement.
 E. t_{PZL} and t_{PHZ} are the same as t_{dis} .
 F. t_{PZL} and t_{PZH} are the same as t_{en} .
 G. t_{PLH} and t_{PHL} are the same as t_{pd} .

Figure 1. Load Circuit and Voltage Waveforms

PACKAGING INFORMATION

| Orderable Device | Status (1) | Package Type | Package Drawing | Pins | Package Qty | Eco Plan (2) | Lead finish/ Ball material (6) | MSL Peak Temp (3) | Op Temp (°C) | Device Marking (4/5) | Samples |
|------------------|---------------|--------------|-----------------|------|-------------|-----------------|--------------------------------------|----------------------|--------------|-------------------------|-------------------------|
| SN74AUC2G79DCTR | ACTIVE | SSOP | DCT | 8 | 3000 | RoHS & Green | NIPDAU SN | Level-1-260C-UNLIM | -40 to 85 | (2XD5, U79) (R, Z) | Samples |
| SN74AUC2G79DCUR | ACTIVE | VSSOP | DCU | 8 | 3000 | RoHS & Green | NIPDAU SN | Level-1-260C-UNLIM | -40 to 85 | (U79Q, U79R) | Samples |
| SN74AUC2G79YZPR | ACTIVE | DSBGA | YZP | 8 | 3000 | RoHS & Green | SNAGCU | Level-1-260C-UNLIM | -40 to 85 | URN | Samples |

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "-" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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TAPE AND REEL INFORMATION

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE


*All dimensions are nominal

| Device | Package Type | Package Drawing | Pins | SPQ | Reel Diameter (mm) | Reel Width W1 (mm) | A0 (mm) | B0 (mm) | K0 (mm) | P1 (mm) | W (mm) | Pin1 Quadrant |
|-----------------|--------------|-----------------|------|------|--------------------|--------------------|---------|---------|---------|---------|--------|---------------|
| SN74AUC2G79DCTR | SSOP | DCT | 8 | 3000 | 177.8 | 12.4 | 3.45 | 4.4 | 1.45 | 4.0 | 12.0 | Q3 |
| SN74AUC2G79DCTR | SSOP | DCT | 8 | 3000 | 180.0 | 13.0 | 3.35 | 4.5 | 1.55 | 4.0 | 12.0 | Q3 |
| SN74AUC2G79DCUR | VSSOP | DCU | 8 | 3000 | 178.0 | 9.5 | 2.25 | 3.35 | 1.05 | 4.0 | 8.0 | Q3 |
| SN74AUC2G79DCUR | VSSOP | DCU | 8 | 3000 | 180.0 | 8.4 | 2.25 | 3.35 | 1.05 | 4.0 | 8.0 | Q3 |
| SN74AUC2G79YZPR | DSBGA | YZP | 8 | 3000 | 178.0 | 9.2 | 1.02 | 2.02 | 0.63 | 4.0 | 8.0 | Q1 |

TAPE AND REEL BOX DIMENSIONS



*All dimensions are nominal

| Device | Package Type | Package Drawing | Pins | SPQ | Length (mm) | Width (mm) | Height (mm) |
|-----------------|--------------|-----------------|------|------|-------------|------------|-------------|
| SN74AUC2G79DCTR | SSOP | DCT | 8 | 3000 | 183.0 | 183.0 | 20.0 |
| SN74AUC2G79DCTR | SSOP | DCT | 8 | 3000 | 182.0 | 182.0 | 20.0 |
| SN74AUC2G79DCUR | VSSOP | DCU | 8 | 3000 | 202.0 | 201.0 | 28.0 |
| SN74AUC2G79DCUR | VSSOP | DCU | 8 | 3000 | 202.0 | 201.0 | 28.0 |
| SN74AUC2G79YZPR | DSBGA | YZP | 8 | 3000 | 220.0 | 220.0 | 35.0 |



4225266/A 09/2014

NOTES:

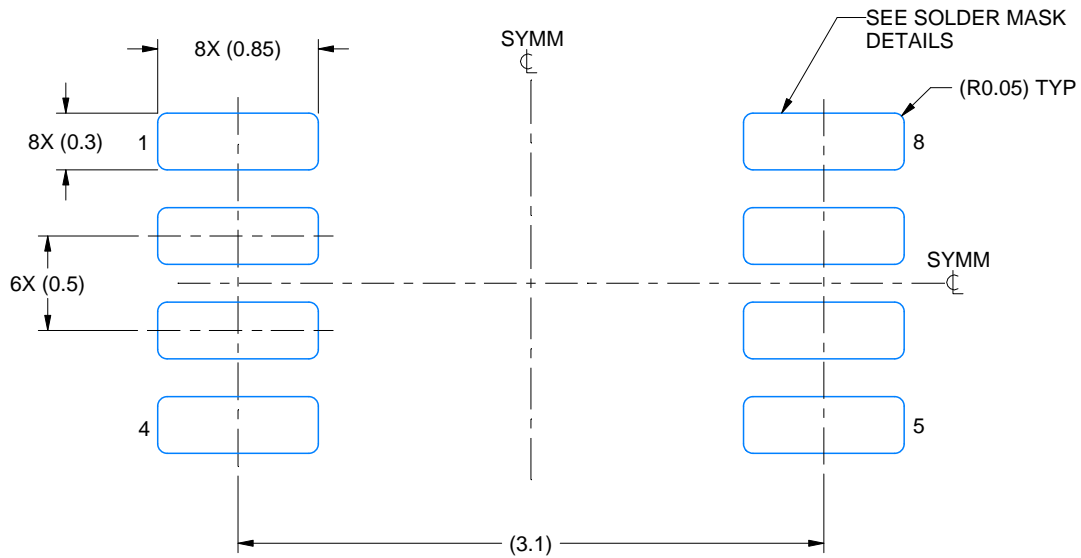
1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm per side.
4. Reference JEDEC registration MO-187 variation CA.

EXAMPLE BOARD LAYOUT

DCU0008A

VSSOP - 0.9 mm max height

SMALL OUTLINE PACKAGE



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE: 25X



4225266/A 09/2014

NOTES: (continued)

- 5. Publication IPC-7351 may have alternate designs.
- 6. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

EXAMPLE STENCIL DESIGN

DCU0008A

VSSOP - 0.9 mm max height

SMALL OUTLINE PACKAGE



SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL
SCALE: 25X

4225266/A 09/2014

NOTES: (continued)

7. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
8. Board assembly site may have different recommendations for stencil design.



4220784/C 06/2021

NOTES:

1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm per side.
4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.

EXAMPLE BOARD LAYOUT

DCT0008A

SSOP - 1.3 mm max height

SMALL OUTLINE PACKAGE



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE:15X



SOLDER MASK DETAILS

4220784/C 06/2021

NOTES: (continued)

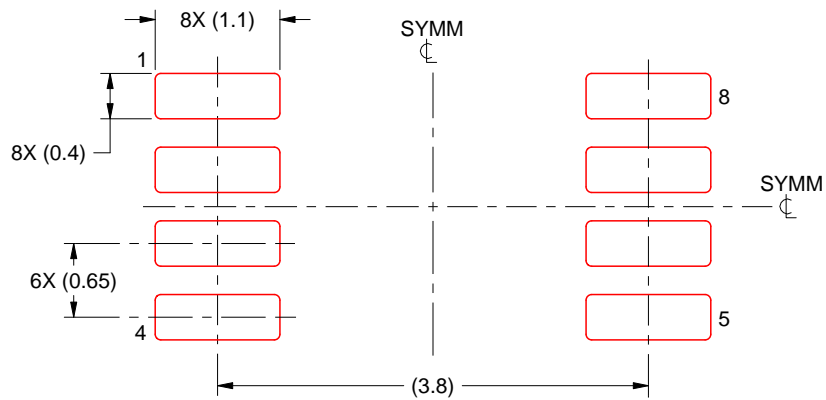
- 5. Publication IPC-7351 may have alternate designs.
- 6. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

EXAMPLE STENCIL DESIGN

DCT0008A

SSOP - 1.3 mm max height

SMALL OUTLINE PACKAGE



SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL
SCALE:15X

4220784/C 06/2021

NOTES: (continued)

7. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
8. Board assembly site may have different recommendations for stencil design.

EXAMPLE BOARD LAYOUT

YZP0008

DSBGA - 0.5 mm max height

DIE SIZE BALL GRID ARRAY



LAND PATTERN EXAMPLE
SCALE:40X



SOLDER MASK DETAILS
NOT TO SCALE

4223082/A 07/2016

NOTES: (continued)

3. Final dimensions may vary due to manufacturing tolerance considerations and also routing constraints. For more information, see Texas Instruments literature number SNVA009 (www.ti.com/lit/snva009).

EXAMPLE STENCIL DESIGN

YZP0008

DSBGA - 0.5 mm max height

DIE SIZE BALL GRID ARRAY



SOLDER PASTE EXAMPLE
BASED ON 0.1 mm THICK STENCIL
SCALE:40X

4223082/A 07/2016

NOTES: (continued)

4. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release.

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